

Mr. James Turner

March 9, 1972

William B. Cridlin, Jr.

Foreign Patent Review

This is to confirm our intention to hold the Foreign Patent Review on March 16th at 9:00 a.m. at the Research Center in Richmond, Va. It is hard to determine how long this meeting will last but hopefully we can accomplish the review within a two to three hour period. There should not be too much discussion on each individual case, and various persons at the lab will make their oral recommendations during the meeting. Essentially the main question to be determined is whether to maintain a particular subject in various foreign countries or simply abandon the subject.

I am enclosing herewith a list which represents our current method of determining which countries to file for foreign patent protection. In the past we have had several people review this list and a meeting has been held to discuss the merits of the proposed foreign filing. To date, we have not had a representative of our International Division to aid us in this review. I am sending this list to you in order that you may get an understanding as to our foreign filing procedure. Perhaps you will have some suggestions on this subject in order that we may obtain some guidance from our International Division concerning future foreign patent filings.

*William B. Cridlin, Jr.*

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WBC:d

Enc.

CC: Dr. H. R. Wakeham  
Dr. P. A. Eichorn

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CC: Dr. H. R. Wakeham  
Dr. P. A. Eichorn

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